JINGMEI LIANG

DIRECTOR, FCVD TECHNOLOGY
DIELECTRIC SYSTEM & MODULE DIVISION



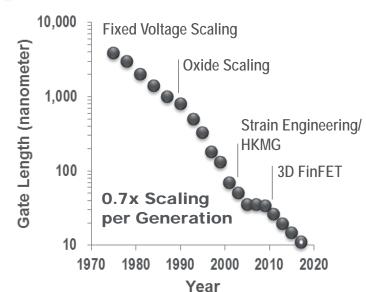
VISION: Define and transform atomic dimension research to high volume industrial production. Design chemical vapor deposition (CVD) processes & reactor chambers for advanced logic & memory chip manufacturing though small geometry (≤10nm), high aspect ratio (≥20:1) dielectric gap fill methods.

TECHNOLOGY CHALLENGE & FOCUS:

- Interoperate, enable new transistor architectures & materials
- Invent diverse gap fill dielectrics for self-aligned patterning

- Create Deposition Method & Reactor Chamber
- Productize for Process Reliability & Stability
 - Validate & Collaborate with Device Chip Makers

	Past	Present	Future
Transistor Feature Size	10,000nm (1971)	14nm (2015)	≤ 5nm
Transistor Count	2,300	1,300,000,000	(in R&D)
Cost per 1000 Transistors	\$150	\$0.0003	:





Applied Materials Producer® GT System